

Click [here](#) for production status of specific part numbers.

## MAX17491

## Single-Phase Synchronous MOSFET Driver

### General Description

The MAX17491 is a single-phase synchronous noninverting MOSFET driver. The MAX17491 is intended to work with controller ICs like the MAX8736, MAX8786, or MAX17030 in multiphase notebook CPU core regulators.

The regulators can either step down directly from the battery voltage to create the core voltage or step down from the main system supply. The single-stage conversion method allows the highest possible efficiency, while the 2-stage conversion at higher switching frequency provides the minimum possible physical size.

The low-side driver is optimized to drive 3nF capacitive loads with 4ns/8ns typical fall/rise times, and the high-side driver with 8ns/10ns typical fall/rise times. Adaptive dead-time control prevents shoot-through currents and maximizes converter efficiency.

The MAX17491 features improved zero crossing and UVLO performance over the MAX8791/MAX8791B.

The MAX17491 is available in a small, lead-free, 8-pin, 3mm x 3mm TQFN package.

### Applications

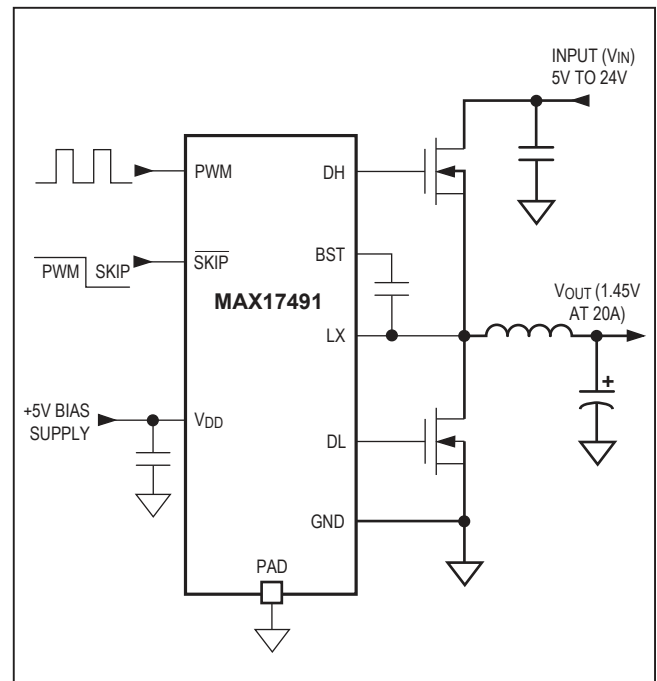
- Notebooks/Desktops/Servers
- CPU Core Power Supplies
- Multiphase Step-Down Converters

[Ordering Information](#) appears at end of data sheet.

### Features

- Single-Phase Synchronous MOSFET Driver
- 0.5Ω Low-Side On-Resistance
- 0.7Ω High-Side On-Resistance
- 10ns Minimum Guaranteed Dead Time
- Integrated Boost “Diode”
- 2V to 24V Input Voltage Range
- Selectable Pulse-Skipping Mode
- Low-Profile, 3mm x 3mm, TQFN Package

### Typical Operating Circuit



### Absolute Maximum Ratings

$V_{DD}$ to GND	-0.3V to +6V	Continuous Power Dissipation	
SKIP to GND	-0.3V to +6V	8-Pin 3mm x 3mm TQFN	
PWM to GND	-0.3V to +6V	(derate 14.4mW/°C above +70°C)	1150mW
DL to GND	-0.3V to ( $V_{DD} + 0.3V$ )	Operating Temperature Range	-40°C to +105°C
BST to GND	-0.3V to +36V	Junction Temperature	+150°C
DH to LX	-0.3V to ( $V_{BST} + 0.3V$ )	Storage Temperature Range	-65°C to +150°C
BST to $V_{DD}$	-0.3V to +30V	Lead Temperature (soldering, 10s)	+300°C
BST to LX	-0.3V to +6V	Soldering Temperature (reflow)	+260°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### Package Information

#### 8 TQFN-EP

Package Code	TQ833+1
Outline Number	<a href="#">21-0136</a>
Land Pattern Number	<a href="#">90-0066</a>
<b>Thermal Resistance, Four-Layer Board:</b>	
Junction to Ambient ( $\theta_{JA}$ )	69.54°C/W*
Junction to Case ( $\theta_{JC}$ )	17.96°C/W

\*Based on JEDEC51-7

For the latest package outline information and land patterns (footprints), go to [www.maximintegrated.com/packages](http://www.maximintegrated.com/packages). Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to [www.maximintegrated.com/thermal-tutorial](http://www.maximintegrated.com/thermal-tutorial).

### Electrical Characteristics

(Circuit of Figure 1,  $V_{DD} = V_{SKIP} = 5V$ ,  $T_A = -40°C$  to +105°C, unless otherwise noted. Typical values are at  $T_A = +25°C$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Voltage Range	$V_{DD}$		4.20		5.50	V
$V_{DD}$ Undervoltage-Lockout Threshold	$V_{UVLO(VDD)}$	Rising edge, PWM disabled below this level		3.7	4.05	V
		Falling edge, PWM disabled below this level	3.30	3.40	3.75	
Quiescent Supply Current ( $I_{DD}$ )	$I_{DD}$	PWM = open; after the shutdown hold time has expired		0.08	0.20	mA
		SKIP = GND, PWM = GND, LX = GND (after zero crossing); this state should be equivalent to low-power standby if LX = GND		0.15	0.30	
		$\overline{SKIP} = GND$ or $V_{DD}$ , PWM = $V_{DD}$ , $V_{BST} = 5V$		0.35	0.70	
<b>DRIVERS</b>						
PWM Pulse Width	$t_{ON(MIN)}$	Minimum on-time		50		ns
	$t_{OFF(MIN)}$	Minimum off-time; required to allow the zero-crossing comparator time to settle to the proper state		300		
DL Propagation Delay	$t_{PWM-DL}$	PWM high-to-DL low		15		ns

## Electrical Characteristics (continued)

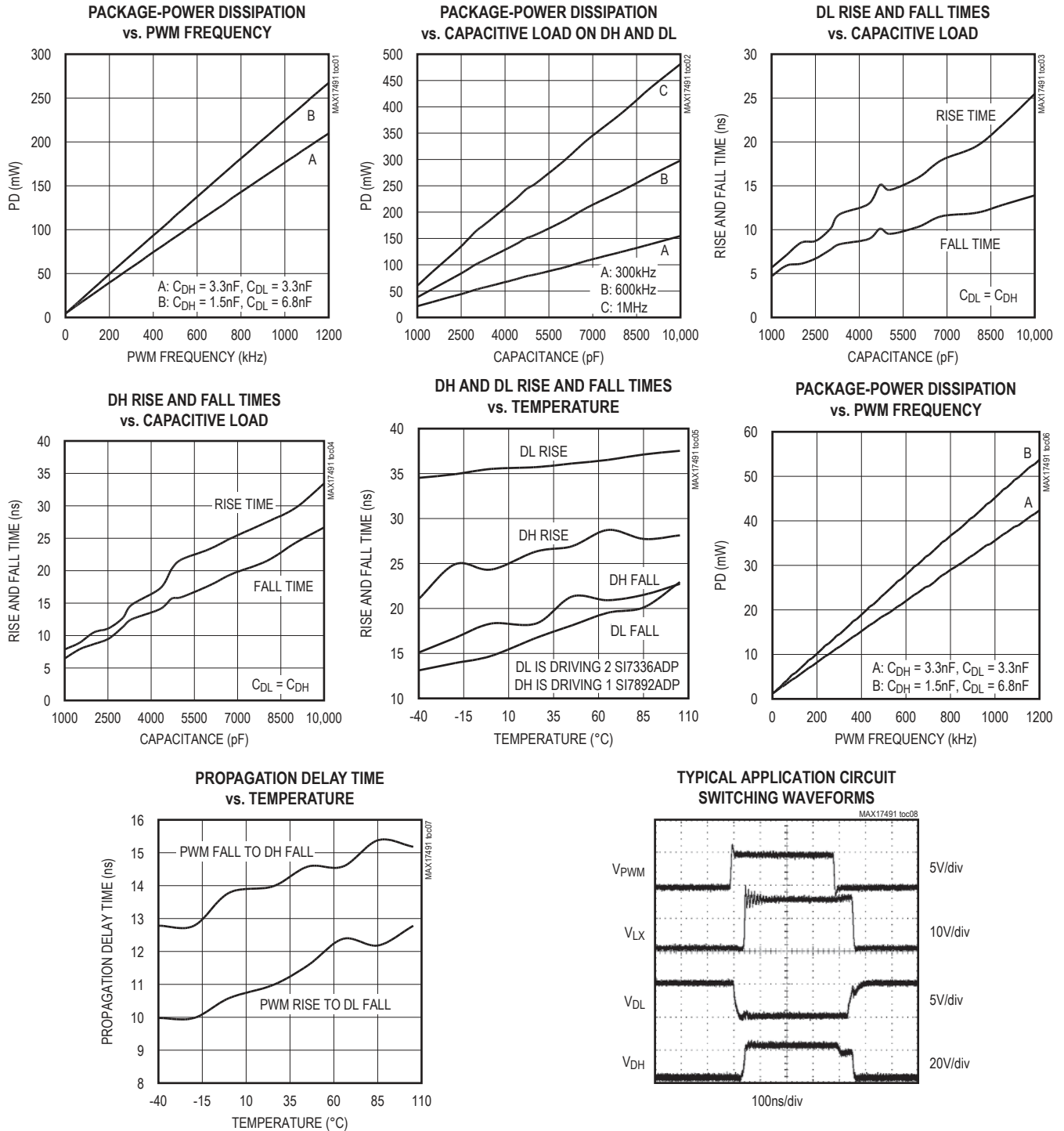
(Circuit of Figure 1,  $V_{DD} = V_{SKIP} = 5V$ ,  $T_A = -40^{\circ}C$  to  $+105^{\circ}C$ , unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
DH Propagation Delay	$t_{PWM-DH}$	PWM low-to-DH low		17		ns
DL-to-DH Dead Time	$t_{DL-DH}$	DL falling to DH rising	$T_A = 0^{\circ}C$ to $+85^{\circ}C$	10		ns
			$T_A = -40^{\circ}C$ to $+105^{\circ}C$	10		
DH-to-DL Dead Time	$t_{DH-DL}$	DH falling to DL rising	$T_A = 0^{\circ}C$ to $+85^{\circ}C$	10		ns
			$T_A = -40^{\circ}C$ to $+105^{\circ}C$	10		
DL Transition Time	$t_{F\_DL}$	Falling, 3.0nF load		10		ns
	$t_{R\_DL}$	Rising, 3.0nF load		12		
DH Transition Time	$t_{F\_DH}$	Falling, 3.0nF load		8		ns
	$t_{R\_DH}$	Rising, 3.0nF load		10		
DH Driver On-Resistance	$R_{ON(DH)}$	BST - LX forced to 5V	DH, high state (pullup)	0.9	2.5	$\Omega$
			DH, low state (pulldown)	0.7	2.1	
DL Driver On-Resistance	$R_{ON(DL)}$	DL, high state (pullup)		0.7	1.6	$\Omega$
		DL, low state (pulldown)		0.3	0.9	
DH Driver Source Current	$I_{DH\_SOURCE}$	DH forced to 2.5V, BST - LX forced to 5V		2.2		A
DH Driver Sink Current	$I_{DH\_SINK}$	DH forced to 2.5V, BST - LX forced to 5V		2.7		A
DL Driver Source Current	$I_{DL\_SOURCE}$	DL forced to 2.5V		2.7		A
DL Driver Sink Current	$I_{DL\_SINK}$	DL forced to 2.5V		8		A
Zero-Crossing Threshold	$V_{ZX}$	GND - LX, SKIP = GND		1.5		mV
Boost On-Resistance	$R_{ON(BST)}$	$V_{DD} = 5V$ , DH = LX = GND (pulldown state), $I_{BST} = 10mA$		5	8	$\Omega$
PWM Input Levels		High (DH = high, DL = low)		$V_{DD} - 0.4$		V
		Midlevel		$V_{DD}/2 - 0.4$	$V_{DD}/2 + 0.4$	
		Low (DH = low, DL = high)			0.4	
PWM Input Current	$I_{PWM}$	Sink; PWM forced to $V_{DD}$	-370	-200	-110	$\mu A$
		Source; PWM forced to GND	110	200	370	
Midlevel Shutdown Hold Time	$t_{MID}$		120	300	600	ns
SKIP Input Threshold		Rising edge		1.7	2.4	V
		Falling edge	0.8	1.5		
SKIP Input Current	$I_{SKIP}$	Sink; SKIP forced to 0.8V to $V_{DD}$ , $T_A = +25^{\circ}C$	-4	-2	-0.5	$\mu A$
Thermal-Shutdown Threshold	$T_{SHDN}$	Hysteresis = $20^{\circ}C$		+160		$^{\circ}C$

**Note 1:** Limits are 100% production tested at  $T_A = +25^{\circ}C$ . Maximum and minimum limits over temperature are guaranteed through correlation using statistical-quality-control (SQC) methods.

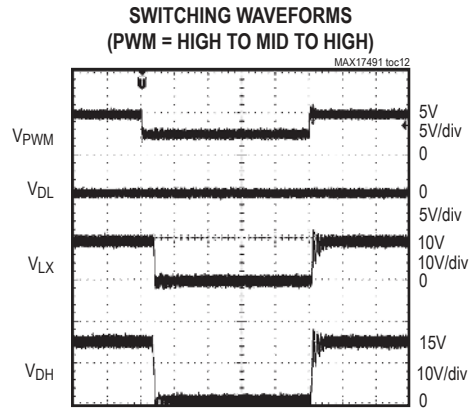
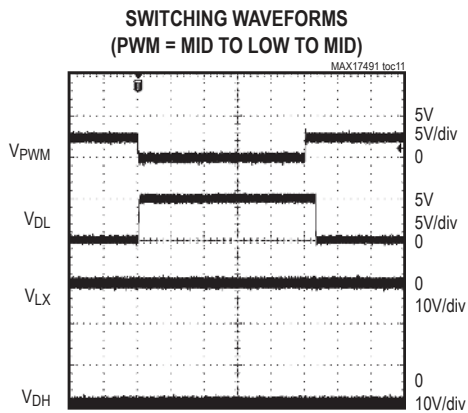
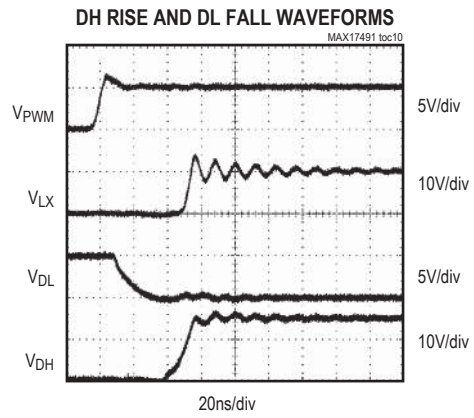
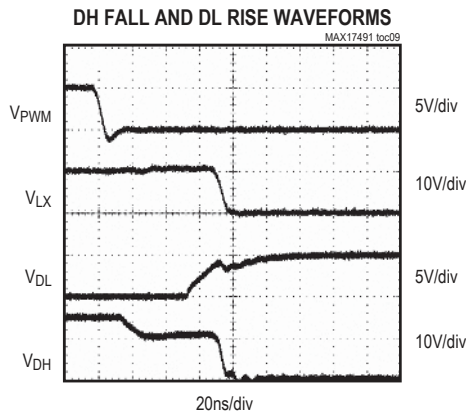
Typical Operating Characteristics

(Circuit of Figure 1,  $V_{DD} = 5V$ ,  $C_{DH} = 3nF$ ,  $C_{DL} = 3nF$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

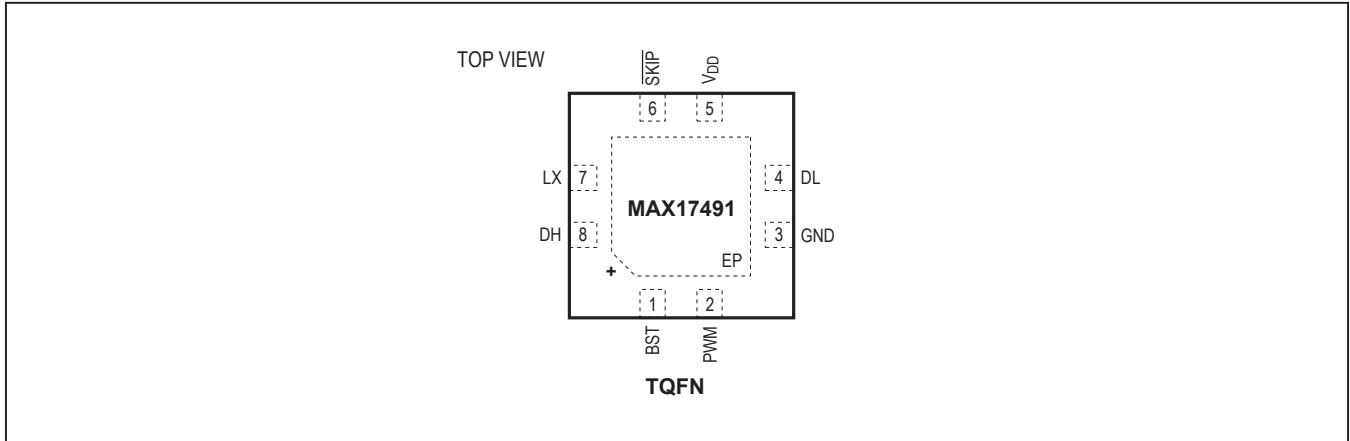


**Typical Operating Characteristics (continued)**

(Circuit of Figure 1,  $V_{DD} = 5V$ ,  $C_{DH} = 3nF$ ,  $C_{DL} = 3nF$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)



Pin Configuration



Pin Description

PIN	NAME	FUNCTION
1	BST	Boost Flying-Capacitor Connection. Gate-drive power supply for DH high-side gate driver. Connect a 0.1µF or 0.22µF capacitor between BST and LX.
2	PWM	PWM Input. Noninverting DH control input from the controller IC: Logic-high: DH = high (BST), DL = low (PGND). Midlevel: After the midlevel hold time expires, the controller enters standby mode. DH and DL pulled low. Logic-low: DH = low (LX), DL = high (V <sub>DD</sub> ) when $\overline{\text{SKIP}}$ = high. Internal pullup and pulldown resistors create the midlevel and prevent the controller from triggering an on-time if this input is left unconnected (not soldered properly) or driven by a high impedance.
3	GND	Power Ground for the DL Gate Drivers and Analog Ground. Connect exposed pad to GND.
4	DL	PWM Low-Side Gate-Driver Output. Swings between GND and V <sub>DD</sub> . DL forced high in shutdown.
5	V <sub>DD</sub>	Supply Voltage Input for the DL Gate Drivers. Connect to 4.2V to 5.5V supply and bypass to GND with a 1µF ceramic capacitor.
6	$\overline{\text{SKIP}}$	Active-Low Pulse-Skipping Mode. Enable pulse-skipping mode (zero-crossing comparator enabled) when the driver is operating in SKIP mode: $\overline{\text{SKIP}} = V_{DD}$ PWM mode $\overline{\text{SKIP}} = \text{GND}$ skip mode An internal pulldown current pulls the controller into the low-power pulse-skipping state if this input is left unconnected (not soldered properly) or driven by a high impedance.
7	LX	Switching Node and Inductor Connection. Low-power supply for the DH high-side gate driver. LX connects to the skip-mode zero-crossing comparator.
8	DH	External High-Side n-Channel MOSFET Gate-Driver Output. Swings between LX and BST.
—	EP	Exposed Pad. Connect to ground through multiple vias to reduce the thermal impedance.

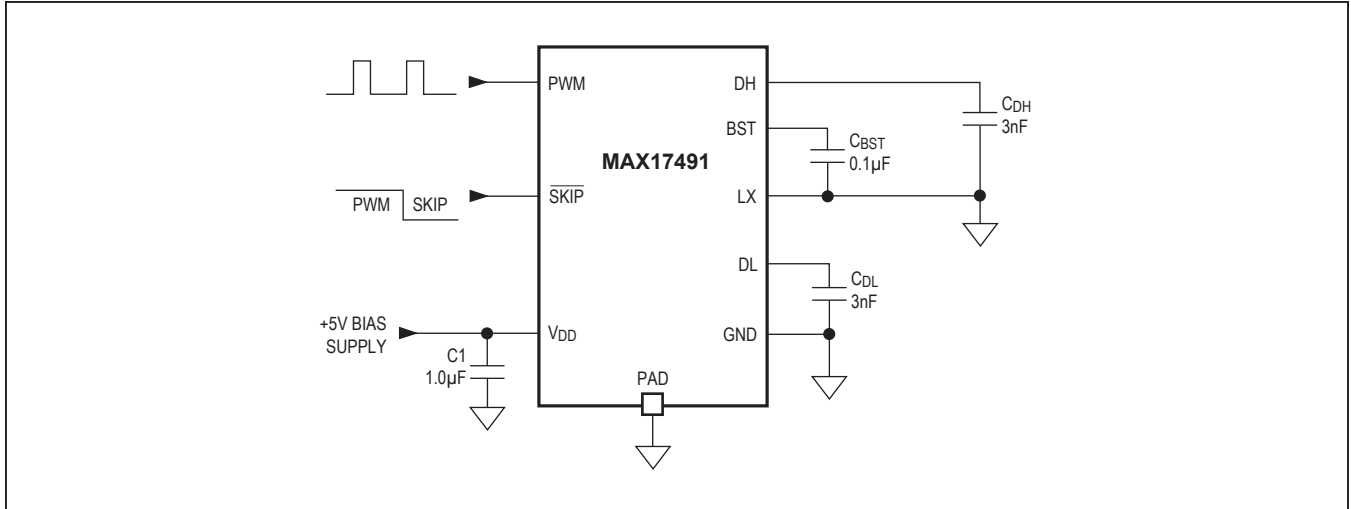


Figure 1. Test Circuit

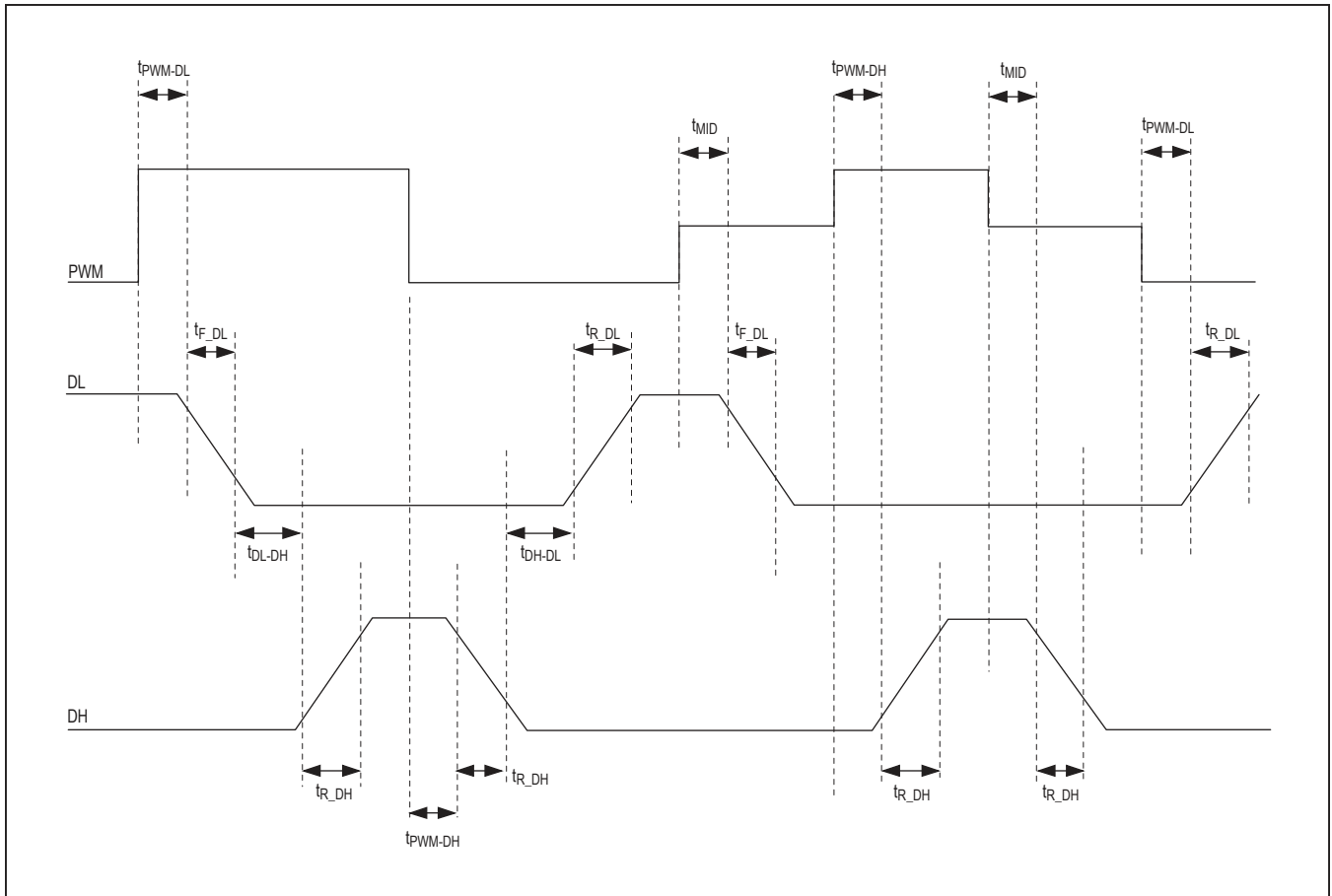


Figure 2. Timing Diagram

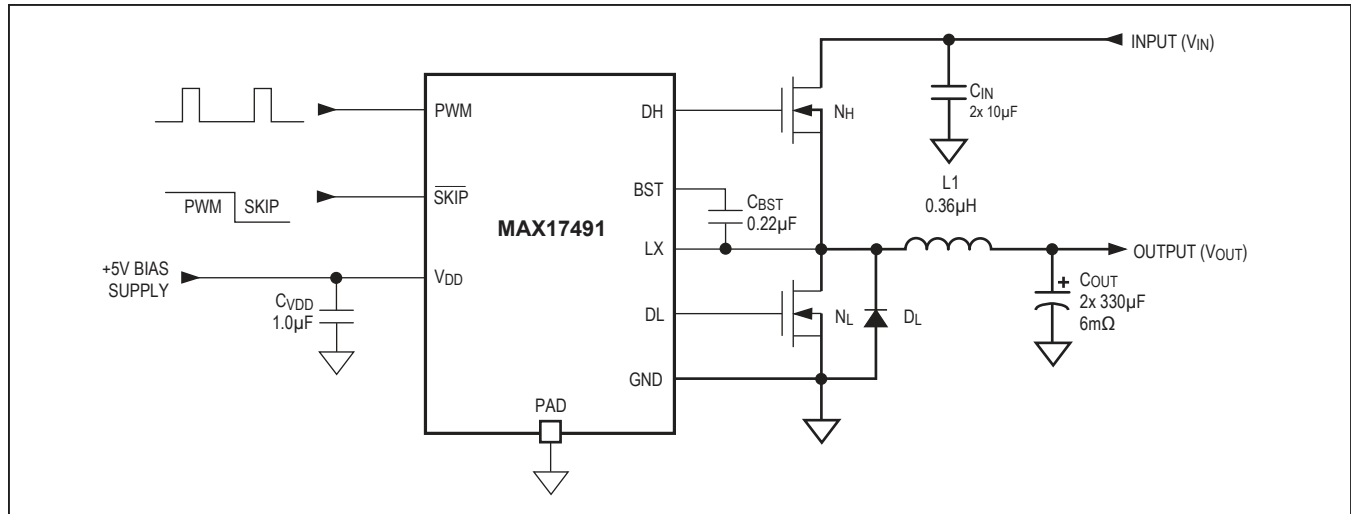


Figure 3. Typical MOSFET-Driver Application Circuit

Table 1. Typical Components

DESIGNATION	QTY	COMPONENT SUPPLIERS
$N_H$	1 per phase	Siliconix Si4860DY
$N_L$	1–2 per phase	Siliconix Si4336DY
BST Capacitor ( $C_{BST}$ )	1 per phase	0.1µF or 0.22µF ceramic capacitor
Schottky Diode	Optional	3A, 40V Schottky diode
Inductor (L1)	1 per phase	0.36µH, 26A, 0.9mΩ power inductor
Output Capacitors ( $C_{OUT}$ )	1–2 per phase	330µF, 6mΩ per phase
Input Capacitors ( $C_{IN}$ )	1–2 per phase	10µF, 25V X5R ceramic capacitors

## Detailed Description

The MAX17491 single-phase gate driver, along with the MAX8736, MAX8786, or MAX17030 multiphase controllers, provide flexible multiphase CPU core-voltage supplies. The low driver resistance allows up to 7A output peak current. Each MOSFET driver in the MAX17491 can drive 3nF capacitive loads with only 9ns propagation delay and 4ns/8ns (typ) fall/rise times, allowing operation up to 3MHz per phase. Larger capacitive loads are allowable but result in longer propagation and transition times. Adaptive dead-time control prevents shoot-through currents and maximizes converter efficiency while allowing operation with a variety of MOSFETs and PWM controllers. An input undervoltage-lockout (UVLO) circuit allows proper power-on sequencing.

## PWM Input

The drivers for the MAX17491 are disabled—DH and DL pulled low—if the PWM input remains in the midlevel window for at least 300ns (typ). Once the PWM signal is driven high or low, the MAX17491 immediately exits the low-current shutdown state and resumes active operation. Outside the shutdown state, the drivers are enabled based on the rising and falling thresholds specified in the *Electrical Characteristics*.

## MOSFET Gate Drivers (DH, DL)

The high-side driver (DH) has a 0.9Ω sourcing resistance and 0.7Ω sinking resistance, resulting in 2.2A peak sourcing current and 2.7A peak sinking current with a 5V supply voltage. The low-side driver (DL) has a typical 0.7Ω sourcing resistance and 0.3Ω sinking resistance, yielding 2.7A peak sourcing current and 8A peak sinking current. This reduces switching losses, making the MAX17491 ideal for both high-frequency and high-output-current applications.





### 5V Bias Supply (V<sub>DD</sub>)

V<sub>DD</sub> provides the supply voltage for the internal logic circuits. Bypass V<sub>DD</sub> with a 1μF or larger ceramic capacitor to GND to limit noise to the internal circuitry. Connect these bypass capacitors as close as possible to the IC.

### Input Undervoltage Lockout

When V<sub>DD</sub> is below the UVLO threshold, DH and DL are held low. Once V<sub>DD</sub> is above the UVLO threshold and while PWM is low, DL is driven high and DH is driven low. This prevents the output of the converter from rising before a valid PWM signal is applied.

### Low-Power Pulse Skipping

The MAX17491 enters into low-power pulse-skipping mode when  $\overline{\text{SKIP}}$  is pulled low. In skip mode, an inherent automatic switchover to pulse-frequency modulation (PFM) takes place at light loads. A zero-crossing comparator truncates the low-side switch on-time at the inductor current's zero crossing. The comparator senses the voltage across LX and GND. Once V<sub>LX</sub> - V<sub>GND</sub> drops below the zero-crossing comparator threshold (see the *Electrical Characteristics*), the comparator forces DL low. This mechanism causes the threshold between pulse-skipping PFM and nonskipping PWM operation to coincide with the boundary between continuous and discontinuous inductor-current operation. The PFM/PWM crossover occurs when the load current of each phase is equal to 1/2 the peak-to-peak ripple current, which is a function of the inductor value. For a battery input range of 7V to 20V, this threshold is relatively constant, with only a minor dependence on the input voltage due to the typically low duty cycles. The switching waveforms can appear noisy and asynchronous when light loading activates the pulse-skipping operation, but this is a normal operating condition that results in high light-load efficiency.

## Applications Information

### Power-MOSFET Selection

Most of the following MOSFET guidelines focus on the challenge of obtaining high load-current capability when using high-voltage (> 20V) AC adapters. Low-current applications usually require less attention. The high-side MOSFET (N<sub>H</sub>) must be able to dissipate the resistive losses plus the switching losses at both V<sub>IN(MIN)</sub> and V<sub>IN(MAX)</sub>. Calculate both these sums. Ideally, the losses at V<sub>IN(MIN)</sub> should be roughly equal to losses at V<sub>IN(MAX)</sub>, with lower losses in between. If the losses at V<sub>IN(MIN)</sub> are significantly higher than the losses at V<sub>IN(MAX)</sub>, consider increasing the size of N<sub>H</sub> (reducing R<sub>DS(ON)</sub> but increasing C<sub>GATE</sub>). Conversely, if the losses at V<sub>IN(MAX)</sub> are significantly

higher than the losses at V<sub>IN(MIN)</sub>, consider reducing the size of N<sub>H</sub> (increasing R<sub>DS(ON)</sub> but reducing C<sub>GATE</sub>). If V<sub>IN</sub> does not vary over a wide range, the minimum power dissipation occurs where the resistive losses equal the switching losses. Choose a low-side MOSFET that has the lowest possible on-resistance (R<sub>DS(ON)</sub>), comes in a moderate-sized package (i.e., one or two 8-pin SOs, DPAK, or D2PAK), and is reasonably priced. Ensure that the DL gate driver can supply sufficient current to support the gate charge and the current injected into the parasitic gate-to-drain capacitor caused by the high-side MOSFET turning on; otherwise, cross-conduction problems can occur.

### MOSFET Power Dissipation

Worst-case conduction losses occur at the duty factor extremes. For the high-side MOSFET (N<sub>H</sub>), the worst-case power dissipation due to resistance occurs at the minimum input voltage:

$$PD(N_H \text{ RESISTIVE}) = \left( \frac{V_{OUT}}{V_{IN}} \right) \left( \frac{I_{LOAD}}{\eta_{TOTAL}} \right)^2 R_{DS(ON)}$$

where η<sub>TOTAL</sub> is the total number of phases. Generally, a small high-side MOSFET is desired to reduce switching losses at high input voltages. However, the R<sub>DS(ON)</sub> required to stay within package-power dissipation often limits how small the MOSFETs can be. Again, the optimum occurs when the switching losses equal the conduction (R<sub>DS(ON)</sub>) losses. High-side switching losses do not usually become an issue until the input is greater than approximately 15V.

Calculating the power dissipation in high-side MOSFETs (N<sub>H</sub>) due to switching losses is difficult since it must allow for difficult quantifying factors that influence the turn-on and turn-off times. These factors include the internal gate resistance, gate charge, threshold voltage, source inductance, and PCB layout characteristics.

The following switching-loss calculation provides only a very rough estimate and is no substitute for prototype evaluation, preferably including verification using a thermocouple mounted on N<sub>H</sub>:

$$PD(N_H \text{ SWITCHING}) = \left( \frac{V_{IN(MAX)} I_{LOAD} f_{SW}}{\eta_{TOTAL}} \right) \left( \frac{Q_{G(SW)}}{I_{GATE}} \right) + \frac{C_{OSS} V_{IN}^2 f_{SW}}{2}$$

where C<sub>OSS</sub> is the N<sub>H</sub> MOSFET's output capacitance, Q<sub>G(SW)</sub> is the charge needed to turn on the high-side MOSFET, and I<sub>GATE</sub> is the peak gate-drive source/sink current (5A typ).

Switching losses in the high-side MOSFET can become an insidious heat problem when maximum AC adapter voltages are applied due to the squared term in the switching-loss equation above. If the high-side MOSFET chosen for adequate  $R_{DS(ON)}$  at low battery voltages becomes extraordinarily hot when biased from  $V_{IN(MAX)}$ , consider choosing another MOSFET with lower parasitic capacitance.

For the low-side MOSFET ( $N_L$ ), the worst-case power dissipation always occurs at the maximum input voltage:

$$PD(N_L \text{ RESISTIVE}) = \left[ 1 - \left( \frac{V_{OUT}}{V_{IN(MAX)}} \right) \right] \left( \frac{I_{LOAD}}{\eta_{TOTAL}} \right)^2 R_{DS(ON)}$$

The worst case for MOSFET power dissipation occurs under heavy load conditions that are greater than  $I_{LOAD(MAX)}$ , but are not quite high enough to exceed the current limit and cause the fault latch to trip. The MOSFETs must have a good-sized heatsink to handle the overload power dissipation. The heatsink can be a large copper field on the PCB or an externally mounted device.

An optional Schottky diode only conducts during the dead time when both the high-side and low-side MOSFETs are off. Choose a Schottky diode with a forward voltage low enough to prevent the low-side MOSFET body diode from turning on during the dead time, and a peak current rating higher than the peak inductor current. The Schottky diode must be rated to handle the average power dissipation per switching cycle. This diode is optional and can be removed if efficiency is not critical.

### IC Power Dissipation and Thermal Considerations

Power dissipation in the IC package comes mainly from driving the MOSFETs. Therefore, it is a function of both switching frequency and the total gate charge of the selected MOSFETs. The total power dissipation when both drivers are switching is given by:

$$PD(IC) = I_{BIAS} \times 5V$$

where  $I_{BIAS}$  is the bias current of the 5V supply calculated in the *5V Bias Supply ( $V_{DD}$ )* section. The rise in die temperature due to self-heating is given by the following formula:

$$\Delta T_J = \theta_{JA} \times PD(IC)$$

where  $PD(IC)$  is the power dissipated by the device, and  $\theta_{JA}$  is the package's thermal resistance. The typical thermal resistance is 69.54°C/W for the 3mm x 3mm TQFN package.

### Avoiding dV/dt Turning on the Low-Side MOSFET

At high input voltages, fast turn-on of the high-side MOSFET can momentarily turn on the low-side MOSFET due to the high dV/dt appearing at the drain of the low-side MOSFET. The high dV/dt causes a current flow through the Miller capacitance ( $C_{RSS}$ ) and the input capacitance ( $C_{ISS}$ ) of the low-side MOSFET. Improper selection of the low-side MOSFET that results in a high ratio of  $C_{RSS}/C_{ISS}$  makes the problem more severe. To avoid this problem, minimize the ratio of  $C_{RSS}/C_{ISS}$  when selecting the low-side MOSFET. Adding a 1Ω to 4.7Ω resistor between BST and  $C_{BST}$  can slow the high-side MOSFET turn-on. Similarly, adding a small capacitor from the gate to the source of the high-side MOSFET has the same effect. However, both methods work at the expense of increased switching losses.

### Layout Guidelines

The MAX17491 MOSFET driver sources and sinks large currents to drive MOSFETs at high switching speeds. The high di/dt can cause unacceptable ringing if the trace lengths and impedances are not well controlled. The following PCB layout guidelines are recommended when designing with the MAX17491:

- 1) Place all decoupling capacitors as close as possible to their respective IC pins.
- 2) Minimize the length of the high-current loop from the input capacitor, the upper switching MOSFET, and the low-side MOSFET back to the input-capacitor negative terminal.
- 3) Provide enough copper area at and around the switching MOSFETs and inductors to aid in thermal dissipation.
- 4) Connect GND of the MAX17491 as close as possible to the source of the low-side MOSFETs.

A sample layout is available in the MAX17030 evaluation kit.

### Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX17491GTA+	-40°C to +105°C	8 TQFN-EP*

+Denotes a lead(Pb)-free/RoHS-compliant package.

\*EP = Exposed pad.

### Chip Information

PROCESS: BiCMOS

## Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	6/10	Initial release	—
1	1/20	Updated the Package thermal resistance values.	2, 11

For pricing, delivery, and ordering information, please visit Maxim Integrated's online storefront at <https://www.maximintegrated.com/en/storefront/storefront.html>.

*Maxim Integrated cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim Integrated product. No circuit patent licenses are implied. Maxim Integrated reserves the right to change the circuitry and specifications without notice at any time. The parametric values (min and max limits) shown in the Electrical Characteristics table are guaranteed. Other parametric values quoted in this data sheet are provided for guidance.*